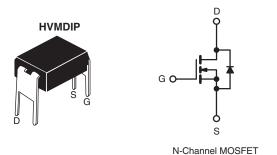


### **Power MOSFET**

PRODUCT SUMMARY				
V <sub>DS</sub> (V)	60			
$R_{DS(on)}\left(\Omega\right)$	$V_{GS} = 5 V$	0.20		
Q <sub>g</sub> (Max.) (nC)	8.4			
Q <sub>gs</sub> (nC)	2.6			
Q <sub>gd</sub> (nC)	6.4			
Configuration	Single			



### **FEATURES**

- Dynamic dV/dt Rating
- · For Automatic Insertion
- End Stackable
- · Logic-Level Gate Drive
- R<sub>DS(on)</sub> Specified at V<sub>GS</sub> = 4 V and 5 V
- 175 °C Operating Temperature
- · Fast Switching
- Compliant to RoHS Directive 2002/95/EC

#### **DESCRIPTION**

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The 4 pin DIP package is a low cost machine-insertiable case style which can be stacked in multiple combinations on standard 0.1" pin centers. The dual drain servers as a thermal link to the mounting surface for power dissipation levels up to 1 W.

ORDERING INFORMATION	
Package	HVMDIP
Lood (Dh) from	IRLD014PbF
Lead (Pb)-free	SiHLD014-E3
SnPb	IRLD014
	SiHLD014

<b>ABSOLUTE MAXIMUM RATINGS</b> (T <sub>A</sub> = 25 °C, unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			$V_{DS}$	60	V	
Gate-Source Voltage			$V_{GS}$	± 10	<b>v</b>	
Continuous Drain Current	V <sub>GS</sub> at 5.0 V	T <sub>A</sub> = 25 °C	- I <sub>D</sub>	1.7	А	
		T <sub>A</sub> = 100 °C		1.2		
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	14		
Linear Derating Factor				0.0083	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	490	mJ	
Maximum Power Dissipation	T <sub>A</sub> = 25 °C		P <sub>D</sub>	1.3	W	
Peak Diode Recovery dV/dtc			dV/dt	4.5	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 175	°C	
Soldering Recommendations (Peak Temperature)	for 10 s			300 <sup>d</sup>		

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b.  $V_{DD}$  = 25 V, starting  $T_J$  = 25 °C, L = 197 mH,  $R_g$  = 25  $\Omega$ ,  $I_{AS}$  = 1.7 A (see fig. 12).
- c.  $I_{SD} \leq$  10 A,  $dI/dt \leq$  90 A/µs,  $V_{DD} \leq V_{DS}, \, T_J \leq$  175 °C.
- d. 1.6 mm from case.

<sup>\*</sup> Pb containing terminations are not RoHS compliant, exemptions may apply

# IRLD014, SiHLD014

# Vishay Siliconix



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	$R_{thJA}$	-	120	°C/W	

PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT		
Static								
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> =	60	-	-	V		
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I <sub>D</sub> = 1 mA	-	0.070	-	V/°C	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$		-	2.0	V	
Gate-Source Leakage	I <sub>GSS</sub>	,	V <sub>GS</sub> = ± 10 V		-	± 100	nA	
Zana Oata Wallana Buit O		V <sub>DS</sub> =	V <sub>DS</sub> = 60 V, V <sub>GS</sub> = 0 V		-	25		
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 48 V,	V <sub>DS</sub> = 48 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 150 °C	-	-	250	μΑ	
Dunin Course On State Besistense	Ъ	V <sub>GS</sub> = 5.0 V	I <sub>D</sub> = 1.0 A <sup>b</sup>	-	-	0.20		
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 4.0 V	I <sub>D</sub> = 0.85 A <sup>b</sup>	-	-	0.28	Ω	
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> = 25 V, I <sub>D</sub> = 1.0 A <sup>b</sup>		1.9	-	-	S	
Dynamic							,	
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V		1-1	400	-	pF	
Output Capacitance	C <sub>oss</sub>		$V_{DS} = 25 \text{ V}$		170	-		
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.0 MHz, see fig. 5		-	42	-		
Total Gate Charge	Qg			-	-	8.4	nC	
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 5.0 V	$I_D = 10 \text{ A}, V_{DS} = 48 \text{ V}$ see fig. 6 and 13 <sup>b</sup>	1-1	-	2.6		
Gate-Drain Charge	Q <sub>gd</sub>		occ ng. o and ro	1-1	-	6.4		
Turn-On Delay Time	t <sub>d(on)</sub>			-	9.3	-	1	
Rise Time	t <sub>r</sub>		V <sub>DD</sub> = 30 V, I <sub>D</sub> = 10 A		110	-	ns	
Turn-Off Delay Time	t <sub>d(off)</sub>	$R_g = 12 \Omega$ , $R_D = 2.8 \Omega$ , see fig. $10^b$		1-1	17	-		
Fall Time	t <sub>f</sub>			1-1	26	-		
Internal Drain Inductance	$L_D$	Between lead, 6 mm (0.25") from package and center of die contact		-	4.0	-	- nH	
Internal Source Inductance	L <sub>S</sub>			-	6.0	-		
Drain-Source Body Diode Characteristic	s						ı	
Continuous Source-Drain Diode Current	Is	MOSFET symbol showing the integral reverse p - n junction diode		-	-	1.7		
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	14	- A	
Body Diode Voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 1.7 A, V <sub>GS</sub> = 0 V <sup>b</sup>		-	-	1.6	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>	- T <sub>J</sub> = 25 °C, I <sub>F</sub> = 10 A, dI/dt = 100 A/μs <sup>b</sup>		-	93	130	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	0.34	0.65	μC	
Forward Turn-On Time	t <sub>on</sub>	Intrinsic tu	-on is don	ninated by	L <sub>S</sub> and I	_D)		

### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq$  300 µs; duty cycle  $\leq$  2 %.





### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

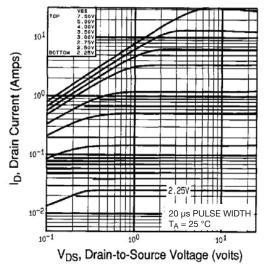


Fig. 1 - Typical Output Characteristics,  $T_A$  = 25 °C

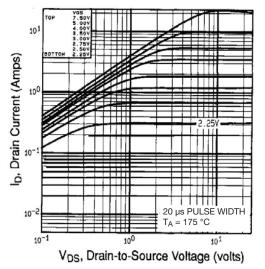


Fig. 2 - Typical Output Characteristics,  $T_A = 175$  °C

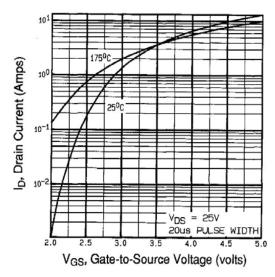


Fig. 3 - Typical Transfer Characteristics

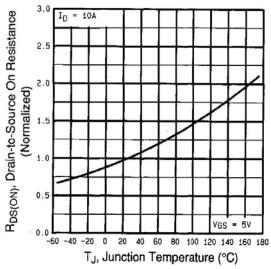


Fig. 4 - Normalized On-Resistance vs. Temperature



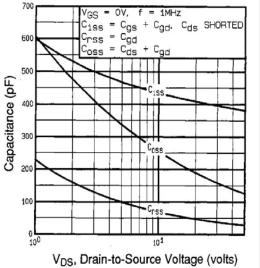


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

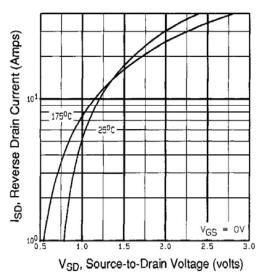


Fig. 7 - Typical Source-Drain Diode Forward Voltage

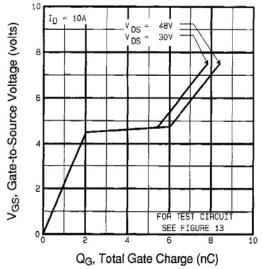


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

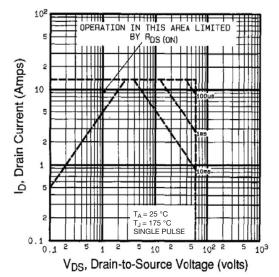


Fig. 8 - Maximum Safe Operating Area





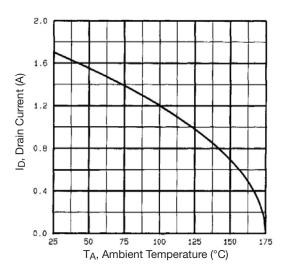


Fig. 9 - Maximum Drain Current vs. Ambient Temperature

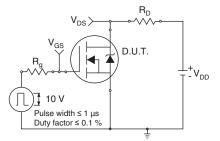


Fig. 10a - Switching Time Test Circuit

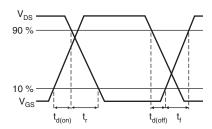


Fig. 10b - Switching Time Waveforms

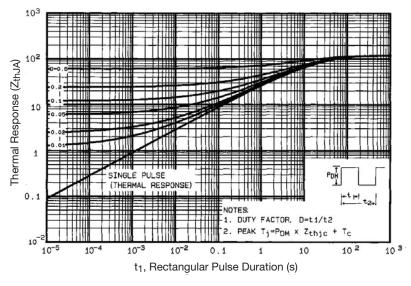


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Ambient



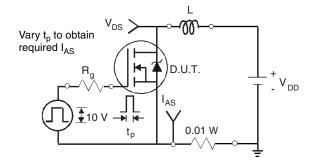


Fig. 12a - Unclamped Inductive Test Circuit

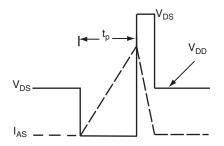


Fig. 12b - Unclamped Inductive Waveforms

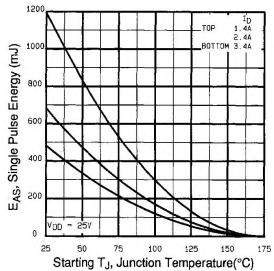


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

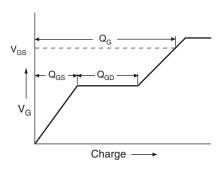


Fig. 13a - Basic Gate Charge Waveform

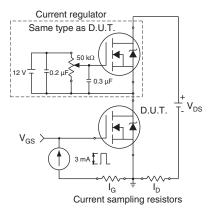
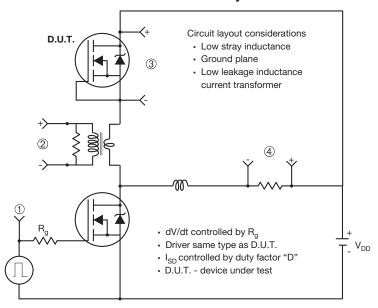


Fig. 13b - Gate Charge Test Circuit



### Peak Diode Recovery dV/dt Test Circuit



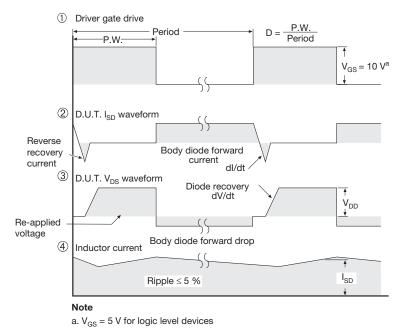


Fig. 14 - For N-Channel

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